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Sheet 1 of 2

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U.S. P	U.S. PATENT DOCUMENTS					
Ref. Desig.	Examiner's Initials	Document Number	Date	Name	Class/ Subclass	(If appropriate) Filing Date
1.		5,894,325		Yonemoto		
2.		7,057,655		Masuyama		
3.		4,335,405		Sakane		
4.		4,589,024		Koch		
5.		5,576,762		Udagawa		

FOREIGN PATENT DOCUMENTS							
Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation Yes	* No
1.		55-145481	11/13/1980	Japan			X
2.		58-070689	4/27/1983	Japan			Х
3.		62-290278	12/17/1987	Japan		Abstract	
4.		63-031280	2/9/1988	Japan		Abstract	
5.		63-112899	5/17/1988	Japan		Abstract	
6.		63-278474	11/16/1988	Japan		Abstract	
7.		64-044178	2/16/1989	Japan		Abstract	
8.		02-246585	10/2/1990	Japan		Abstract	
9.		04-172880	6/19/1992	Japan			Х
10.		08-336076	12/17/1996	Japan			Х
11.		09-116804	5/2/1997	Japan		Abstract	
12.		63-037782	2/18/1998	Japan		Abstract	
13.		2000-125203	4/28/2000	Japan			Х
14.		2000-324398	11/24/2000	Japan		Abstract	
15.		2001-008109	1/12/2001	Japan		Abstract	

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9319S-000597	10/763,126
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Masahiro KANAI	
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1/22/2004	2811

FOREIGN PATENT DOCUMENTS							
Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation Yes	* No
16.		2001-008113	1/12/2001	Japan		Abstract	
17.		2001-189909	7/10/2001	Japan		Abstract	
18.		2002-344894	11/29/2002	Japan		Abstract	

OTHE	OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)				
Ref. Desig.	Examiner's Initials	Communication from Japanese Patent Office regarding counterpart application.			

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